#### Successive Refinement of Models for Model-Based Testing to Increase System Test Effectiveness

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#### Outline

- Testing Challenges in Consumer Electronics Domain
- Model-based Testing and System Models
- Overall Approach
- Model Updates and Case Study
- Results and Future Work

# Challenges



- Short time-to-market
- Limited resources
- Large code base • 5M LOC in total
- Large models

   Thousands of states and transitions
- Importance of User
   Perception

# Model-based Testing (MBT)

• Automated test case generation based on models that represent the desired behavior of the system under test (SUT)



Effective test case generation;

- Focus on features that are **mostly used**
- Focus on scenarios that are mostly error-prone
- Focus on scenarios that reveal different failures

# System Models used for MBT



Hierarchical Markov chains defined with the **MaTeLo tool** (http://www.all4tec.net)

# **Overall Approach**

- Update system models based on;
  - Frequency of usage by the end-users
  - Estimated risk of failure based on static analysis
  - Estimated risk of failure based on dynamic analysis
- (Re)generate and execute test cases



# System Model Updates

• First assignments of transition probabilities based on number of visits recorded in the usage profile

• Next: second & third updates based on estimated risk of error



# Update based on Risk of Error

- Risk estimations:
  - Static analysis: Ratio of static code analysis alerts
  - Dynamic analysis: Ratio of memory leaks
- Example: Update of the system model after the probability of error for state s is calculated as 0.2



## Industrial Case Study

 Initial model was previously developed by the software test group in the company.

Data Collection and Estimations;

- Usage Profile
- Static Analysis\*
- Memory Profile



#### \* Performed with the **Klockwork tool** (http://www.klocwork.com/)

### Model Updates



#### Iterations

Software	Iteration 1		Iteration 2		Iteration 3	
Module	# of Visits	Calculated Prob.	# of Warnings	Calculated Prob.	Memory leak (MB)	Calculated Prob.
Portal	1900	0.146	18	0.322	40.855	0.218
Youtube	2250	0.173	18	0.322	89.380	0.477
HBBTV	500	0.038	6	0.108	8.846	0.047
MBR Video	1750	0.134	2	0.036	22.375	0.119
MBR Audio	400	0.03	1	0.017	4.167	0.022
MBR Picture	100	0.007	1	0.017	3.980	0.021
PVR	1000	0.076	3	0.054	9.351	0.05
Channel List	1750	0.134	3	0.054	2.516	0.013
EPG	2000	0.153	2	0.036	3.094	0.017
Teletext	1250	0.096	1	0.017	1.675	0.009
HDMI-SCART	100	0.007	1	0.017	1.002	0.005

### **Results and Future Work**

- Reduction in the number of test cases
- Detection of new faults

Iteration #	# of Test Cases	Test Execution Time (hr)	# of Faults Detected	# of New Faults Detected
0	847	4	7	2
1	809	4	9	2
2	136	1.5	3	1
3	117	1.5	3	2

- Different types of fault/error states
- Test execution time vs. fault detection trade-off
  - Eliminating iterations
  - Updating only once by aggregating estimations

#### Conclusions

- Challenging context of the consumer electronics
   domain
- Testing focus on mostly used, error-prone scenarios
- An iterative model refinement approach
- Detection of new faults in each iteration

#### Thanks! Questions welcome..

